

Vishay Siliconix

# N-Channel 40 V (D-S) MOSFET



PRODUCT SUMMARY					
V <sub>DS</sub> (V)	40				
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 10 \text{ V}$	0.00179				
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 4.5 \text{ V}$	0.00236				
Q <sub>g</sub> typ. (nC)	130				
I <sub>D</sub> (A)	150 <sup>d</sup>				
Configuration	Single				

#### **FEATURES**

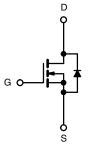
- TrenchFET® power MOSFET
- Maximum 175 °C junction temperature



- Excellent R<sub>DS</sub>-Q<sub>q</sub> and R<sub>DS</sub>-Q<sub>oss</sub> FOM reduce power loss from conduction and switching to enable high efficiency
- 100 % R<sub>q</sub> and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

#### **APPLICATIONS**

- Power supply
  - Secondary synchronous rectification
- DC/DC converter
- Power tools
- · Motor drive switch
- · Battery management



N-Channel MOSFET

ORDERING INFORMATION			
Package	TO-220		
Lead (Pb)-free and halogen-free	SUP40012EL-GE3		

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage		V <sub>DS</sub>	40	V	
Gate-source voltage		V <sub>GS</sub>	± 20		
Continuous dusin surrent /T 150 °C)	T <sub>C</sub> = 25 °C		150 <sup>d</sup>		
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 70 °C	l <sub>D</sub>	150 <sup>d</sup>		
Pulsed drain current (t = 100 μs)		I <sub>DM</sub>	300	A	
Avalanche current	I <sub>AS</sub>	50			
Single avalanche energy <sup>a</sup>	L = 0.1 mH	E <sub>AS</sub>	125	mJ	
Maximum power dissipation <sup>a</sup>	T <sub>C</sub> = 25 °C	PD	150 b	W	
Maximum power dissipation -	T <sub>C</sub> = 125 °C		50 b		
Operating junction and storage temperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C		

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	LIMIT	UNIT	
Junction-to-ambient (PCB mount) <sup>c</sup>	R <sub>thJA</sub>	40	°C/M	
Junction-to-case (drain)	R <sub>thJC</sub>	1	°C/W	

- a. Duty cycle ≤ 1 %
- b. See SOA curve for voltage derating
- c. When mounted on 1" square PCB (FR4 material)
- d. Package limited



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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static				•		
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40	-	-	
Gate threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1	-	2.5	V
Gate-body leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 250	nA
Zero gate voltage drain current		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	-	-	1	. ^
	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	150	- μA
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 175 ^{\circ}\text{C}$	-	-	5	mA
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	120	=	-	Α
Drain-source on-state resistance a	В	$V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$	-	0.00149	0.00179	Ω
Drain-source on-state resistance "	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	-	0.00196	0.00236	
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 30 \text{ A}$	-	230	-	S
Dynamic <sup>b</sup>						
Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V, f = 1 MHz	-	10 930	-	pF
Output capacitance	C <sub>oss</sub>		-	2041	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	101	-	
Total gate charge <sup>c</sup>	Qg		-	130	195	
Gate-source charge <sup>c</sup>	Q <sub>gs</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	33.6	-	nC
Gate-drain charge <sup>c</sup>	$Q_{gd}$		-	6.7	-	
Output charge	Q <sub>oss</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	-	64	96	
Gate resistance	R <sub>g</sub>	f = 1 MHz	0.36	1.8	3.6	Ω
Turn-on delay time <sup>c</sup>	t <sub>d(on)</sub>		-	25	50	
Rise time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = 20 \text{ V}, R_L = 2 \Omega$	-	12	24	
Turn-off delay time <sup>c</sup>	t <sub>d(off)</sub>	$I_D\cong 10~A,~V_{GEN}=10~V,~R_g=1~\Omega$	-	65	130	- ns
Fall time <sup>c</sup>	t <sub>f</sub>		-	18	36	
Drain-Source Body Diode Ratings	and Characte	ristics <sup>b</sup> (T <sub>C</sub> = 25 °C)				
Pulsed current (t = 100 μs)	I <sub>SM</sub>		-	-	300	Α
Forward voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>F</sub> = 10 A, V <sub>GS</sub> = 0 V	-	0.8	1.5	V
Reverse recovery time	t <sub>rr</sub>		-	58	116	ns
Peak reverse recovery charge	I <sub>RM(REC)</sub>		-	2.1	4.2	Α
Reverse recovery charge	Q <sub>rr</sub>	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	72	144	nC
Reverse recovery fall time	ta		-	32	-	nc
Reverse recovery rise time	t <sub>b</sub>		-	26	-	ns

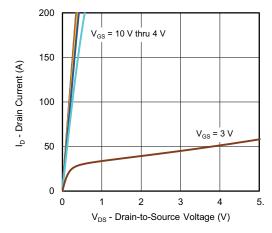
#### Notes

- a. Pulse test; pulse width  $\leq 300~\mu\text{s},$  duty cycle  $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing
- c. Independent of operating temperature

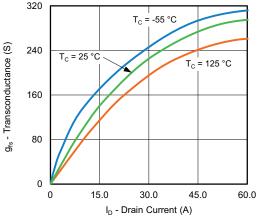
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



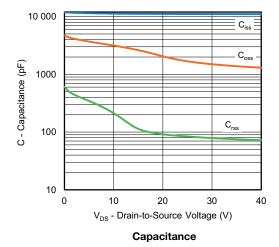
## **TYPICAL CHARACTERISTICS** (T<sub>A</sub> = 25 °C, unless otherwise noted)

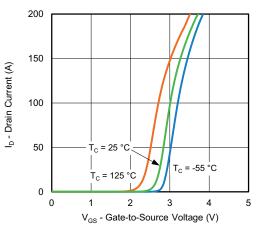


### **Output Characteristics**

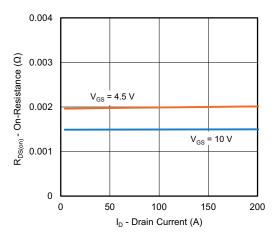


Transconductance

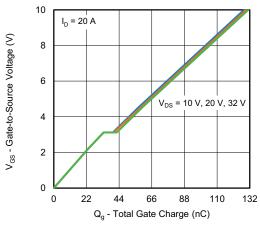




**Transfer Characteristics** 



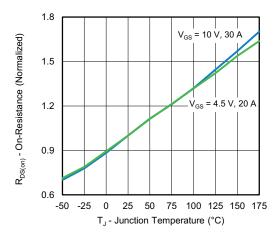
**On-Resistance vs. Drain Current** 



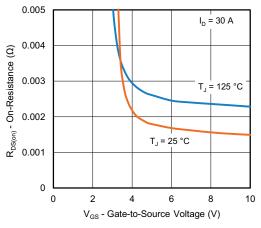
**Gate Charge** 



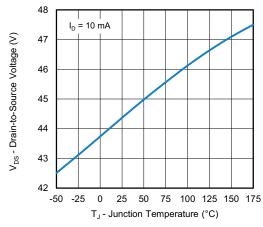
## **TYPICAL CHARACTERISTICS** (T<sub>A</sub> = 25 °C, unless otherwise noted)



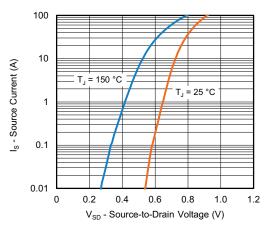
On-Resistance vs. Junction Temperature



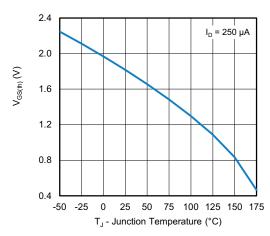
On-Resistance vs. Gate-to-Source Voltage



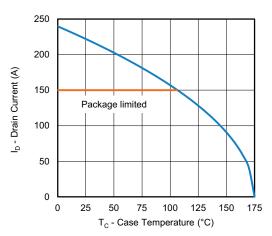
Drain Source Breakdown vs. Junction Temperature



**Source Drain Diode Forward Voltage** 



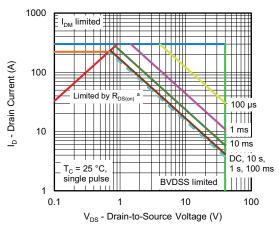
**Threshold Voltage** 

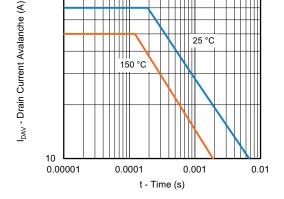


**Current De-rating** 



## **THERMAL RATINGS** (T<sub>A</sub> = 25 °C, unless otherwise noted)





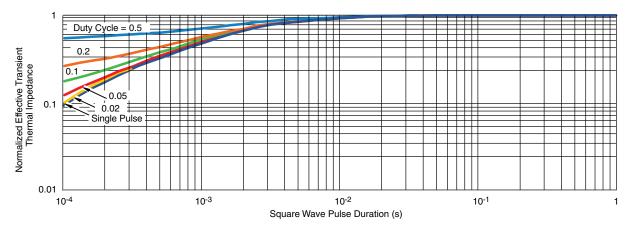
100

Safe Operating Area

Single Pulse Avalanche Current Capability vs. Time

#### Note

a.  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified



Normalized Thermal Transient Impedance, Junction-to-Case

## Note

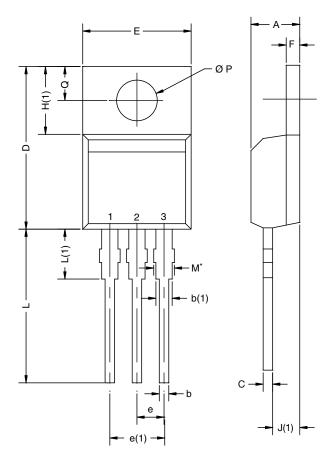
- The characteristics shown in the two graphs
  - Normalized Transient Thermal Impedance Junction to Ambient (25 °C)
  - Normalized Transient Thermal Impedance Junction to Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual pplication parameters and operating conditions

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg276965">www.vishay.com/ppg276965</a>.



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## **TO-220AB**



	D2

	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
D2	12.19	12.70	0.480	0.500
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: T14-0413-Rev. P, 16-Jun-14 DWG: 5471				

#### Note

 $<sup>^{\</sup>star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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